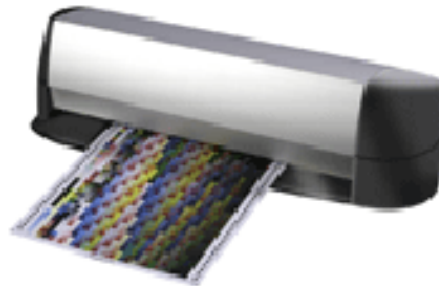


X-RITE iSIS MEASURING DEVICE

The X-Rite iSis measuring device can be driven with or without a UV filter, a feature which sets it apart from other measuring devices. This document describes what to observe when using the X-Rite iSis measuring device with EFI XF.



Setting in EFI XF

The X-Rite iSis measuring device is equipped with a UV filter whose use/non-use is controlled by two separate drivers.

In EFI XF, there are two separate settings. This setting defines which operating mode is used, as illustrated in the table below:

| Device setting in EFI XF | Method of measurement |
|---------------------------|--|
| X-Rite Eye-One iSis | Switches electronically between UV-cut and non-UV-cut filter |
| X-Rite Eye-One iSis UVCut | Measures with UV-cut filter only |

Facts and figures

The following table contains some technical information about the X-Rite iSis measuring device:

| | |
|---|--|
| Size | Available in two sizes: <ul style="list-style-type: none"> The standard model supports media sizes up to A4+/Letter The XL version can print charts up to A3+/Tabloid size |
| Speed | Approx. 4 minutes to scan the ECI 2002 chart |
| Max. number of patches that can be measured | <ul style="list-style-type: none"> 1,000 patches (A4+/Letter) 2,500 patches (A3+/Tabloid) |